



EIA STANDARD

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TP-110

Thermal Cycling Test Procedure for Electrical Connectors and Sockets

EIA/ECA-364-110

August 2006



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CONTENTS

Clause		Page
1	Introduction	1
1.1	Scope	1
2	Test resources	1
2.1	Test equipment	1
3	Test specimen	1
3.1	Description	1
3.2	Preparation	1
4	Test procedure	2
5	Details to be specified	4
6	Test documentation	4
Table		
1	Test condition	3
2	Test duration	3